

Notice of References Cited

Application/Control No.

09/754,439

Applicant(s)/Patent Under
Reexamination
WEIGL ET AL.

Examiner

Raymond Phan

Art Unit

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6539443	03-2003	Dunstan et al.	710/106
	B	US-6442708	08-2002	Dierauer et al.	714/25
	C	US-6167061	12-2000	Nakatsugawa	370/480
	D	US-6542947	04-2003	Buhring	710/107
	E	US-6548969	04-2003	Ewbank et al.	318/34
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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